§ 18.309

paragraph shall be based on the measurement of the radio frequency voltage between each power line and ground at the power terminal using a 50 $\mu H/50$ ohms line impedance stabilization network (LISN).

(a) All Induction cooking ranges and ultrasonic equipment:

Frequency of emission (MHz)	Conducted limit (dBμV)	
sion (MHz)	Quasi-peak	Average
0.009–0.05 0.05–0.15 0.15–0.5 0.5–5 5–30		— 56 to 46* 46 50

^{*} Decreases with the logarithm of the frequency.

(b) All other part 18 consumer devices:

Frequency of emission (MHz)	Conducted limit (dBμV)	
	Quasi-peak	Average
0.15–0.5 0.5–5 5–30	66 to 56* 56	56 to 46* 46 50

^{*}Decreases with the logarithm of the frequency.

(c) RF lighting devices:

Frequency (MHz)	Maximum RF line voltage measured with a 50 uH/50 ohm LISN (uV)
Non-consumer equipment:	1,000
0.45 to 1.6	3,000

Frequency (MHz)	Maximum RF line voltage measured with a 50 uH/50 ohm LISN (uV)
Consumer equipment: 0.45 to 2.51	250 3,000 250

- (d) If testing with a quasi-peak detector demonstrates that the equipment complies with the average limits specified in the appropriate table in this section, additional testing to demonstrate compliance using an average detector is not required.
- (e) These conduction limits shall apply only outside of the frequency bands specified in §18.301.
- (f) For ultrasonic equipment, compliance with the conducted limits shall preclude the need to show compliance with the field strength limits below 30 MHz unless requested by the Commission.
- (g) The tighter limits shall apply at the boundary between two frequency ranges.

[50 FR 36067, Sept. 5, 1985, as amended at 52 FR 43198, Nov. 10, 1987; 64 FR 37419, July 12, 1999; 67 FR 45671, July 10, 2002]

§18.309 Frequency range of measurements.

(a) For field strength measurements:

Frequency band in which device	Range of frequency measurements		
operates (MHz)	Lowest frequency	Highest frequency	
Below 1.705	Lowest frequency generated in the device, but not lower than 9 kHz.	30 MHz.	
1.705 to 30	Lowest frequency generated in the device, but not lower than 9 kHz.	400 MHz.	
30 to 500	Lowest frequency generated in the device or 25 MHz, whichever is lower.	Tenth harmonic or 1,000 MHz, whichever is higher.	
500 to 1,000	Lowest frequency generated in the device or 100 MHz, which- ever is lower.	Tenth harmonic.	
Above 1,000	do	Tenth harmonic or highest detectable emission.	

(b) For conducted powerline measurements, the frequency range over which the limits are specified will be scanned.

[50 FR 36070, Sept. 5, 1985, as amended at 51 FR 17971, May 16 1986]

§ 18.311 Methods of measurements.

The measurement techniques which will be used by the FCC to determine

compliance with the technical requirements of this part are set out in FCC Measurement Procedure MP-5, "Methods of Measurements of Radio Noise Emissions from ISM equipment". Although the procedures in MP-5 are not mandated, manufacturers are encouraged to follow the same techniques which will be used by the FCC.